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Substrate Form PTO-1449 (Mos) ed)

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 17268-005001

Application No. 10/799,855

Information Disclosure Statement
by Applicant
(Use several sheets if necessary)

Hitoshi Takeda et al.

Filing Date

Applicant

Group Art Unit

(37 CFR §1.98(b))

March 12, 2004

U.S. Patent Documents Publication Filing Date Examiner Desig. Document If Appropriate Class **Subclass** Initial ID Number Date Patentee BH 09/16/2004 20040179367 Takeda et al. AA AB 20040179368 09/16/2004 Takeda et al. BH Takeda et al. AC 20040178737 09/16/2004 AD ΑE AF AG AH ΑI ΑJ ΑK

Foreign Patent Documents or Published Foreign Patent Applications									
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Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No	
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	sclosure Statement pplicant	Applicant Hitoshi Takeda et al.		
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